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## Simultaneously Efficient Light Absorption and Charge Separation in WO<sub>3</sub>/BiVO<sub>4</sub> Core/Shell Nanowire Photoanode for Photoelectrochemical Water Oxidation

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#### **Abstract**

We report a scalably-synthesized WO<sub>3</sub>/BiVO<sub>4</sub> core/shell nanowire photoanode in which BiVO<sub>4</sub> is the primary light-absorber and WO<sub>3</sub> acts as an electron conductor. These core/shell nanowires achieve the highest product of light absorption and charge separation efficiencies among BiVO<sub>4</sub>-based photoanodes to date and, even without an added catalyst, produce a photocurrent of 3.1 mA/cm<sup>2</sup> under simulated sunlight and an incident photon-to-current conversion efficiency of ~60% at 300-450 nm, both at a potential of 1.23 V vs. RHE.

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## Simultaneously Efficient Light Absorption and Charge Separation in WO<sub>3</sub>/BiVO<sub>4</sub> Core/Shell Nanowire Photoanode for Photoelectrochemical Water Oxidation

Pratap M. Rao,<sup>ठ</sup> Lili Cai,<sup>‡†</sup> Chong Liu,<sup>#</sup> In Sun Cho,<sup>†</sup> Chi Hwan Lee,<sup>†</sup> Jeffrey M. Weisse,<sup>†</sup> Peidong Yang<sup>#§</sup> and Xiaolin Zheng<sup>†</sup>\*

Photoelectrochemical (PEC) water-splitting produces hydrogen using solar energy and is an example of artificial photosynthesis, by which the energy of sunlight is converted to chemical fuels. Due to the large voltage required for water-splitting and the desirability of small band gaps for efficient light absorption, a two-electrode tandem system in which a photocathode and photoanode are connected in series and the water-splitting reaction is divided into two half reactions, promises to be more efficient than a single semiconductor system. However, the efficiency of these proposed tandem systems is presently limited by the low photocurrents achieved by the oxygen-evolving photoanodes. However, the commonly-studied binary oxides TiO<sub>2</sub><sup>10, 11</sup> and WO<sub>3</sub><sup>12</sup> have band gaps that are too large to absorb light efficiently ( $\sim 3.0$  and  $\sim 2.6$  eV, respectively), while the-commonly studied Fe<sub>2</sub>O<sub>3</sub>, despite its desirable band gap of  $\sim 2.2$  eV, has a conduction band edge at 0.55 V vs. the reversible hydrogen electrode (RHE), which is further from the vacuum level than desired for a PEC photoanode, and extremely poor charge transport properties which have prevented efficient charge separation.

Recently, the ternary oxide BiVO<sub>4</sub> has become the top-performer amongst all metal oxide photoanodes due to its relatively small bandgap of 2.4 eV which permits efficient light absorption, its relatively negative conduction band edge (~ 0 V vs. RHE), and moderate charge transport properties.<sup>6, 17, 18</sup> Theoretically, the maximum water oxidation photocurrent ( $J_{max}$ ) for BiVO<sub>4</sub> photoanodes under Air-Mass 1.5 Global (AM 1.5G) solar illumination is 7.5 mA/cm<sup>2, 17</sup> Nevertheless, the practical water oxidation photocurrent ( $J_{H_2O}$ ) is much lower due to the limited light absorption, charge separation and surface charge transfer efficiencies ( $\eta_{abs}$ ,  $\eta_{sep}$  and  $\eta_{trans}$ , respectively) of the BiVO<sub>4</sub> material, according to  $J_{H_2O} = J_{max} \times \eta_{abs} \times \eta_{sep} \times \eta_{trans}$ . <sup>13, 19, 20</sup> Various efforts have been devoted to increase these efficiencies. Specifically, the charge transfer efficiency  $\eta_{trans}$  has been dramatically improved by coating oxygen evolution reaction (OER) catalysts onto the BiVO<sub>4</sub> surface for improving the water oxidation kinetics and/or passivating surface defects. <sup>6, 18, 19, 21-29</sup> The charge separation efficiency  $\eta_{sep}$  of BiVO<sub>4</sub> has been improved by a range of methods, including introduction of nanoscale porosity, <sup>6, 19, 21, 22, 24, 26, 27, 30, 31</sup> reduction of BiVO<sub>4</sub> thickness, <sup>6, 25</sup> introduction of electron-donating dopants such as Mo and W, <sup>6, 19, 22, 27, 32-35</sup> and formation of a distributed homojunction by the introduction of a gradient doping concentration of W in a BiVO<sub>4</sub> film. <sup>18</sup> Moreover,  $\eta_{sep}$  has also been improved by the

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formation of heterojunctions of BiVO<sub>4</sub> with other materials including films (SnO<sub>2</sub>, <sup>18, 25, 36-38</sup> SiO<sub>2</sub><sup>39</sup>, WO<sub>3</sub>, <sup>35, 40-42</sup> graphene<sup>43</sup> and others<sup>44, 45</sup>) and nanowires (WO<sub>3</sub> <sup>46, 47</sup> and Fe<sub>2</sub>O<sub>3</sub><sup>48</sup>). Amongst the latest state-of-the-art BiVO<sub>4</sub>-based photoanodes, the highest efficiency was achieved by a W-doped BiVO<sub>4</sub> film with gradient doping of W and an underlying SnO<sub>2</sub> heterojunction, synthesized on a textured substrate, and coated with cobalt phosphate (CoPi) OER catalyst, for which  $\eta_{abs}$ ,  $\eta_{sep}$  and  $\eta_{trans}$  were reported at the reversible water oxidation potential of 1.23 V vs. RHE as 75%, 60% and nearly 100%, respectively. <sup>18</sup> Though  $\eta_{trans}$  at 1.23 V vs. RHE has approached nearly 100% by the use of OER catalysts, the achieved  $\eta_{abs} \times \eta_{sep}$  product is only 45% because the hole and electron diffusion lengths are shorter than the light absorption depth. <sup>6</sup>, <sup>19, 25, 37</sup> Hence, achieving simultaneously high  $\eta_{abs}$  and  $\eta_{sep}$  remains a challenge and needs to be addressed in order to realize high performance BiVO<sub>4</sub> photoanodes for PEC water oxidation.

In this study, we demonstrate a photoanode that achieves the highest reported  $\eta_{abs} \times \eta_{sep}$ product (53%) among BiVO<sub>4</sub>-based photoanodes by coating a thin layer of BiVO<sub>4</sub> onto a vertical array of electrically conductive WO<sub>3</sub> nanowires (NWs) to form WO<sub>3</sub>/W-doped BiVO<sub>4</sub> core/shell NWs (WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs, Fig. 1a). In this structure, BiVO<sub>4</sub> is the primary light-absorber and WO<sub>3</sub> acts as an electron conductor. Such core/shell NWs successfully incorporate all the previously mentioned strategies for enhancing charge separation in BiVO<sub>4</sub>, including thickness reduction, introduction of nanoscale porosity, heterojunction formation and gradient doping, into a single structure. In addition, they permit efficient light absorption by orthogonalizing the directions of light absorption and charge transport in BiVO<sub>4</sub> and further improve charge separation by providing a conductive pathway through the WO<sub>3</sub> NW cores for electrons to reach the current collector. Though a WO<sub>3</sub>/BiVO<sub>4</sub> core/shell nanorod photoanode<sup>46</sup> and a WO<sub>3</sub> NW/BiVO<sub>4</sub> heterojunction photoanode<sup>47</sup> have been attempted before, the efficiency of the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NW photoanodes is higher because of superior morphology which simultaneously optimizes light absorption and charge transport. In the following, we will describe the synthesis and characterization of the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs in detail and explain the origin of the improved PEC performance.

The WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs were synthesized by a combination of flame vapor deposition and drop-casting. First, flat fluorine-doped tin oxide (FTO) substrates (2.5 x 1.7 cm, 2.3 mm thick, 8  $\Omega$ / $\square$ , Hartford Glass) were cleaned and completely coated with a layer of 70-100 nm-thick tungsten oxide by spin-coating, in order to promote uniform and dense nucleation of the NWs. An Next, crystalline substoichiometric W<sub>18</sub>O<sub>49</sub> NWs were synthesized on the coated FTO substrates via atmospheric flame vapor deposition at a substrate temperature of 550 °C for 30 minutes, as reported in our previous work. This flame-synthesis method is rapid, economical and scalable, which is important for practical applications. The as-grown W<sub>18</sub>O<sub>49</sub> NWs were further annealed in air at 550 °C in a box furnace for 2 hours, after which stoichiometric WO<sub>3</sub> NWs were obtained (Fig. 1b). Next, a solution containing 50 mM bismuth and 46.5 mM vanadium prepared by dissolving bismuth nitrate pentahydrate (98%) and vanadyl acetylacetonate (98%) in 20:1 (v/v) acetic acid (99.7%): acetyl acetone (99%) was coated onto the WO<sub>3</sub> NWs by drop-casting. 6 coats of the solution, in total, were applied to each sample. For each coat, 20  $\mu$ L was dropped on the sample, which was allowed to dry at room temperature and

then briefly annealed on a hotplate at 450 °C for 2 minutes. Finally, after all the coating steps, the samples were annealed in air at 550 °C in a box furnace for 2 hours to yield a crystalline W-doped BiVO<sub>4</sub> shell composed of a single layer of densely packed nanoparticles on the WO<sub>3</sub> NWs (Fig. 1c). Here, W was naturally doped into BiVO<sub>4</sub> during the annealing process because of the intimate contact of WO<sub>3</sub> and BiVO<sub>4</sub> in the core/shell structure, as will be described next.

The morphologies, crystal structures and chemical composition of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs were characterized by scanning electron microscopy (SEM, FEI Sirion XL30, 5 kV), parallel beam X-ray diffraction (XRD, PANalyticalXPert 2, Cu-kα, 45 kV, 40 mA), transmission electron microscopy (TEM, FEI Tecnai G2 F20 X-TWIN FEG, 200 kV) and TEMenergy dispersive X-ray spectroscopy (TEM-EDS). Monoclinic WO<sub>3</sub> and monoclinic W:BiVO<sub>4</sub> are the only phases detected in XRD measurements (Fig. 2a). The XRD pattern of the WO<sub>3</sub> NWs is nearly unchanged after adding the W:BiVO<sub>4</sub> shell and the average W doping in the W:BiVO<sub>4</sub> shell is approximately 7%, as estimated from the magnitude of the shift of the W:BiVO<sub>4</sub> XRD peaks from those of undoped BiVO<sub>4</sub> (Supporting Information Fig. S3). 19, 32, 33 It is known that W<sup>6+</sup> dopes into BiVO<sub>4</sub> by substituting for V<sup>5+</sup>, and acts as an electron donor.<sup>32</sup> For this reason, the Bi-V drop-casting solution was formulated to contain Bi:V = 100:93, with 7% W-doping coming from the WO3 NWs. In addition, the TEM-EDS (Fig. 2b) clearly shows that there is considerable inter-diffusion of the elements across the core/shell interface, and the sum of the V and W concentrations is approximately equal to the Bi concentration in the shell, as would be expected for W-doped BiVO<sub>4</sub>. Moreover, there is a concentration gradient of W in the BiVO<sub>4</sub> shell, with the highest W concentration near the WO<sub>3</sub> core and decreasing W concentration across the shell. The best-performing photoanode consists of WO<sub>3</sub> NWs with average lengths of 2.5 µm, average diameters of 75 nm and average inter-wire spacing of 350 nm, coated with a W:BiVO<sub>4</sub> layer of 60 nm average thickness (see Supporting Information Fig. S1 and S2 for additional SEM images and a histogram of NW diameters).

The PEC performance of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NW photoanode (masked to expose an illuminated area of 0.63 cm<sup>2</sup>) was evaluated by measuring the current density-voltage (J-V) curve and incident photon-to-current conversion efficiency (IPCE) plot under electrolyteside illumination (as shown in Fig. 1a) in aqueous 0.5 M potassium phosphate solution that is buffered to pH 8. The electrochemical measurement was performed in a three-electrode configuration with the photoanode as the working electrode, a saturated calomel (SCE) reference electrode, and a Pt wire (0.8 mm<sup>2</sup> surface area) as the counter electrode, using a potentiostat (Model SP-200, BioLogic). Potentials are reported vs. RHE using V vs. RHE (volt) = V vs. SCE (volt) +  $[0.059 \text{ (volt)} \times \text{pH}] + 0.244 \text{ (volt)}$ . J-V curves were measured at a scan rate of 50 mV/sec, under illumination from a class-AAA solar simulator (Model 94063A, Oriel), with the total intensity measured by a calibrated silicon solar cell and readout meter (Model 91150V, Newport). Although it is common to simply use an overall illumination intensity of 100 mW/cm<sup>2</sup> for J-V measurements, this can introduce errors because of the significant spectral mismatch between the AM 1.5G standard and the lamp output. Therefore, to ensure that the illumination closely simulates the AM 1.5G standard, we measured the spectral irradiance of the illumination at the sample location using a spectrometer (Ocean Optics) and adjusted the overall intensity to 85 mW/cm<sup>2</sup> to achieve the desired 7.5 mA/cm<sup>2</sup> integrated photon current up to the 515 nm bandedge wavelength of BiVO<sub>4</sub> (illumination spectrum at sample is provided and compared to AM 1.5G spectrum in Supporting Information Fig. S4). IPCE was measured at 1.23 V vs. RHE using a 75 W Xe lamp equipped with a monochromator (CM-110, 1/8 m, Spectra Products). The incident light intensity at each wavelength was measured by a calibrated silicon photodiode, and is given in Supporting Information Fig. S4. The IPCE was calculated from IPCE (%) =  $[J_{ph}$  (mA/cm<sup>2</sup>) × 1240 (volt × nm)]/ $[P_{mono}$  (mW/cm<sup>2</sup>) ×  $\lambda$  (nm)] × 100%, where  $J_{ph}$  is the photocurrent density,  $P_{mono}$  is the intensity of the incident monochromatic light, and  $\lambda$  is the wavelength of the monochromatic light.<sup>20</sup> During all J-V and IPCE measurements, the electrolyte was purged with Ar to remove dissolved oxygen and prevent signals from oxygen reduction.

The photocurrent of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs (*J-V* curve in Fig. 3a) reaches 3.1 mA/cm<sup>2</sup> at a potential of 1.23 V vs. RHE under the simulated AM 1.5G illumination, and closely matches the photocurrent of 3.0 mA/cm<sup>2</sup> obtained by integrating the measured IPCE (Fig. 3b) over the standard AM 1.5G spectrum. These photocurrent values of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs without the addition of OER catalysts are quite close to that achieved at the same potential by the best-performing W-gradient doped BiVO<sub>4</sub> photoanode with an OER catalyst added for which, although a value of 3.6 mA/cm<sup>2</sup> was reported at 1.23 V vs. RHE under simulated illumination, a value of ~3.4 mA/cm<sup>2</sup> is obtained by multiplying  $J_{max}$  (7.5 mA/cm<sup>2</sup>) by the reported  $\eta_{abs}$  of 75% and the reported  $\eta_{sep}$  of 60% at 1.23 V vs. RHE, even if  $\eta_{trans}$ = 100%. <sup>18</sup> Apart from that best-performing W-gradient doped BiVO<sub>4</sub> photoanode, for which IPCE was not reported, the average IPCE of our WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs over the 300-450 nm range at 1.23 V vs. RHE is about 60%, which is the highest for any BiVO<sub>4</sub>-based photoanode at this potential, including those with added OER catalysts. <sup>6, 19, 26, 27, 40, 42, 47</sup>

To evaluate possible synergistic effects between WO<sub>3</sub> and W:BiVO<sub>4</sub> in the core/shell NWs, J-V curves (Fig. 3a) and IPCEs (Fig. 3b) were also measured for the bare WO<sub>3</sub> NW array and a porous 1.5 µm-thick 7% W-doped BiVO<sub>4</sub> film containing the same mass of Bi as that in the core/shell NWs (hereafter referred to as the 'same-mass W:BiVO4 film', SEM images provided in Supporting Information Fig. S1). 7% W-doping was chosen because it matches the average doping level in the W:BiVO<sub>4</sub> shell of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs. The same-mass W:BiVO<sub>4</sub> film was prepared by drop-casting a solution containing B:V:W = 100:93:7 onto bare FTO glass, with drop-casting and subsequent annealing steps identical to those used for the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs. The W ions were obtained by dissolution of H<sub>2</sub>WO<sub>4</sub> in 30% aqueous H<sub>2</sub>O<sub>2</sub> followed by dilution in deionized water. As shown in Fig. 3a, while the WO<sub>3</sub> NWs and samemass W:BiVO<sub>4</sub> film separately generate photocurrents of 1.1 and 0.4 mA/cm<sup>2</sup> at 1.23 V vs. RHE, respectively, the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs generate a photocurrent of 3.1 mA/cm<sup>2</sup> at 1.23 V vs. RHE, which is more than twice the sum of the separate photocurrents, indicating a powerful synergistic effect between the WO<sub>3</sub> core and the W:BiVO<sub>4</sub> shell. This synergy is also evident in the IPCE results (Fig. 3b, measured at 1.23 V vs. RHE). As will de described next, light in the 300-515 nm wavelength range is primarily absorbed in the W:BiVO<sub>4</sub> shell, since it is the outer material and a stronger light-absorber than WO<sub>3</sub>. Nevertheless, the average IPCE of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs over the 300-450 nm wavelength range (~60 %) is more than four times higher than that of the

same-mass W:BiVO<sub>4</sub> film (13%), and is similar to the maximum IPCE of the WO<sub>3</sub> NWs. This indicates that the WO<sub>3</sub> NWs are improving the collection efficiency of charges generated in W:BiVO<sub>4</sub>, which is a synergistic effect. In other words, these IPCE results suggest that the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs utilize the best properties of each component in that they absorb light like BiVO<sub>4</sub>, and have charge transport properties similar to WO<sub>3</sub>, as will be elaborated next.

Next, we determine the reasons for the excellent performance of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs by extracting the efficiencies of the sub-processes  $\eta_{abs}$ ,  $\eta_{sep}$ , and  $\eta_{trans}$  and comparing them, as appropriate, to those of the bare WO<sub>3</sub> NWs and same-mass W:BiVO<sub>4</sub> film. The wavelength-dependent optical absorption properties of the samples were obtained with an integrating sphere using illumination from a Xe lamp coupled to a monochromator. For the absorption measurements, the samples were placed in the center of the sphere, with light incident normal to the sample surface. For the reflectance measurements, the samples were aligned to a port at the backside of the integrating sphere and the reflectance spectra were normalized to the reflection of a white standard. A calibrated silicon photodiode at a second port was used to measure the unabsorbed and reflected light, respectively. Firstly, the light absorption spectrum of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs (Fig. 4a) closely resembles that of BiVO<sub>4</sub>, with absorption onset at 515 nm (~2.4 eV) and a smooth rise to nearly complete absorption at 450nm. Since the bare WO<sub>3</sub> NWs hardly absorb any light at these wavelengths, the strong light absorption by the core/shell NWs, especially around 450 nm, indicates that light absorption occurs efficiently in the W:BiVO<sub>4</sub> shell despite the small W:BiVO<sub>4</sub> shell thickness of only 60 nm, which is far below the light absorption depth of about 250 nm at 450 nm. 19,53 This strong absorption can be attributed to the long path for light, which is equal to the NW length, through the W:BiVO4 shell. Based on the strong absorption at these longer wavelengths and since it is the outer material, the W:BiVO<sub>4</sub> shell should absorb most of the light in the entire 300-515 nm wavelength range. Nevertheless, some light of wavelength shorter than 460 nm will also enter the WO<sub>3</sub> NW cores through their tips where the W:BiVO<sub>4</sub> coating is very thin, and be absorbed by WO<sub>3</sub>. Moreover,  $\eta_{abs}$  of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs, when the absorption is integrated over the AM 1.5G spectrum, is 69%, which is slightly higher than the 66%  $\eta_{abs}$  of the 1.5  $\mu$ m-thick porous same-mass W:BiVO<sub>4</sub> film due to reduced reflection by the NWs (Supporting Information Fig. S5). Nevertheless, the light absorption enhancement is much smaller than the over four-fold IPCE enhancement between the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs and same-mass W:BiVO<sub>4</sub> film, indicating that light absorption is not the main reason for the difference in performance of these photoanodes.

The charge separation and surface transfer efficiencies  $\eta_{sep}$  and  $\eta_{trans}$  are determined by adding a fast hole scavenger to the electrolyte.<sup>4,21</sup> Specifically, J-V curves were measured with 0.5 M H<sub>2</sub>O<sub>2</sub> added to the 0.5 M potassium phosphate electrolyte as a hole scavenger. Since the rate of charge transfer to the electrolyte by oxidation of H<sub>2</sub>O<sub>2</sub> at the semiconductor/electrolyte interface is very fast, it can be assumed that the surface recombination of charges is eliminated and  $\eta_{trans}(H_2O_2) \approx 100\%$ . While the H<sub>2</sub>O oxidation photocurrent is given by  $J_{H_2O} = J_{max} \times \eta_{abs} \times \eta_{sep} \times \eta_{trans}$ , the H<sub>2</sub>O<sub>2</sub> oxidation photocurrent is given by  $J_{H_2O_2} \approx J_{max} \times \eta_{abs} \times \eta_{sep}$ . Since the addition of H<sub>2</sub>O<sub>2</sub> did not change the light absorption, pH or flat band potentials of the photoanodes, and the saturated photocurrents for H<sub>2</sub>O and H<sub>2</sub>O<sub>2</sub> oxidation were the same for

each electrode, indicating that no current doubling occurs in the presence of  $H_2O_2$ ,  $J_{max}$ ,  $\eta_{abs}$  and  $\eta_{sep}$  are the same for  $J_{H_2O_2}$  and  $J_{H_2O}$ . As shown in Fig. 4b, when  $H_2O_2$  is added to the electrolyte, the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs generate a photocurrent nearly equal to 4.0 mA/cm<sup>2</sup> at 1.23 V vs. RHE under precisely simulated AM 1.5G illumination, indicating that the  $\eta_{abs} \times \eta_{sep}$  (= $J_{H_2O_2}/J_{max}$ ) product equals 53%, which is the highest value for any reported BiVO<sub>4</sub>-based photoanode. The photocurrent onset at around 0.45 V vs. RHE is close to the flat band potential of WO<sub>3</sub> (~0.4 V vs. RHE <sup>41</sup>), as expected. Importantly, these high photocurrents at potentials below 1.23 V vs. RHE could be achieved for H<sub>2</sub>O oxidation by the addition of OER catalysts. Such a photoanode would then be extremely promising for PEC water-splitting with a tandem photocathode which would supply the necessary bias and perform H<sub>2</sub>O reduction.

Moreover, the charge separation and surface transfer efficiencies can be individually calculated as  $\eta_{sep} \approx J_{H_2O_2}/(J_{max} \times \eta_{abs})$  and  $\eta_{trans} \approx J_{H_2O}/J_{H_2O_2}$ , and are plotted in Fig 4c and 4d, respectively. The  $\eta_{trans}$  of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs (78%) is higher than that of the porous same-mass W:BiVO<sub>4</sub> film (62%) at 1.23 V vs. RHE, perhaps indicating that the surface area of the NWs is higher than that of the porous film. However, this is not sufficient to explain the nearly 8 times higher photocurrent of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs at 1.23 V vs. RHE, which means that the improvement must primarily come from increased  $\eta_{sep}$ . As expected, charge separation in the same-mass 1.5 µm-thick polycrystalline W:BiVO<sub>4</sub> (13% at 1.23 V vs. RHE) is extremely poor due to strong bulk recombination, since the average particle radius of 250 nm is larger than the hole diffusion length in W:BiVO<sub>4</sub> (70-100nm<sup>19, 54, 55</sup>) and the film thickness is much larger than the 300-nm electron diffusion length.<sup>6</sup> On the other hand, charge separation in the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs (77% at 1.23 V vs. RHE) is relatively more efficient.

Next, we examine the reasons for the high charge separation efficiency of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs. Charges are generated mostly by light absorption in the W:BiVO<sub>4</sub> shell, and to a smaller extent by light absorption in the WO<sub>3</sub> NW cores. First, considering charges generated in the 60-nm thick W:BiVO<sub>4</sub> shell, holes can readily reach the semiconductor/electrolyte interface because they only need to travel a short distance that is less than the reported hole diffusion length (70-100nm<sup>19, 54, 55</sup>) in W-doped BiVO<sub>4</sub>. Holes generated in the W:BiVO<sub>4</sub> shell also have a low probability of reaching and recombining at defect states at the FTO/semiconductor interface<sup>25, 37</sup> because WO<sub>3</sub>, due to its lower-lying valence band, serves as a 'hole mirror'. For electrons, their diffusion lengths in W:BiVO<sub>4</sub> and WO<sub>3</sub> are ~300<sup>6</sup> and ~500nm, <sup>56</sup> respectively, which are shorter than the length of the NWs, so the electron transport to the current collector will rely on drift and hence prefer the high electrical conductivity pathway. The axial electron conductivity of the WO<sub>3</sub> NWs (I-V curve and experimental details in Supporting Information Fig. S6) is determined to be on the order of 1 S/cm, which is much higher than that of the 7%-W:BiVO<sub>4</sub> film (10<sup>-8</sup> S/cm) estimated by an impedance measurement (Nyquist plot and experimental details in Supporting Information Fig. S7). Hence, electrons generated in the W:BiVO<sub>4</sub> shell will first travel radially inwards to the WO<sub>3</sub> cores, and then travel to the current collector through WO3. In addition, apart from the small thickness of the W:BiVO<sub>4</sub> shell, the electric fields due to the gradient W-doping<sup>18</sup> and the staggered type-II WO<sub>3</sub>/W:BiVO<sub>4</sub> heterojunction<sup>41, 46</sup> also significantly improve  $\eta_{sen}$  as evidenced by the fact that  $\eta_{sep}$  in an undoped BiVO<sub>4</sub> layer of similar thickness was reported to be only 20% at 1.23 V vs. RHE.<sup>25</sup> Second, as seen by comparing to  $\eta_{sep}$  of the bare WO<sub>3</sub> NWs (Fig. 4c), charges generated in the 75-nm diameter WO<sub>3</sub> NW cores also have high  $\eta_{sep}$ . Holes can readily reach the electrolyte by first transferring to W:BiVO<sub>4</sub> across the WO<sub>3</sub>/W:BiVO<sub>4</sub> heterojunction since the NW diameter is smaller than the hole diffusion length of ~150 nm.<sup>57</sup> Electrons can reach the current collector directly and efficiently because of the high electrical conductivity of WO<sub>3</sub>. Therefore, as a result of efficient charge separation in both the core and shell, the charge separation efficiency in the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs is much higher than that in the samemass W:BiVO<sub>4</sub> film.

Compared to the recent top-performer, a 200-nm thick gradient-doped compact W:BiVO<sub>4</sub> film synthesized on a textured substrate which achieved  $\eta_{abs} \approx 75\%$  and  $\eta_{sep} \approx 60\%$  at 1.23 V vs. RHE, 18 the  $\eta_{abs}$  of the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs (69%) is very similar despite the small BiVO<sub>4</sub> thickness of 60 nm due to the long optical path for light absorption along the NW length. At the same time,  $\eta_{sep}$  of the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs (77%) is significantly higher due to the small BiVO<sub>4</sub> thickness (60 nm vs. 200 nm), and the presence of the conductive WO<sub>3</sub> NW pathway for electron transport. The efficiency of the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NW photoanodes is also higher than that of a previously-reported WO<sub>3</sub>/BiVO<sub>4</sub> core/shell nanorod photoanode<sup>46</sup> and a WO<sub>3</sub> NW/BiVO<sub>4</sub> heterojunction photoanode, <sup>47</sup> for a number of reasons. In the case of the previously reported WO<sub>3</sub>/BiVO<sub>4</sub> core/shell nanorods, <sup>46</sup> a thin BiVO<sub>4</sub> layer was deposited onto short (500-1000 nm) WO<sub>3</sub> nanorods which had a hexagonal crystal structure. In the present study, we synthesize longer (2.5 µm) WO<sub>3</sub> NWs with a higher surface area, which permits a higher BiVO<sub>4</sub> loading and therefore higher light absorption, and with a monoclinic WO<sub>3</sub> crystal structure which results in faster electron transport compared to the hexagonal structure, therefore allowing more efficient charge separation. In the case of the previously reported WO<sub>3</sub> NW/BiVO<sub>4</sub> heterojunction, which achieved a photocurrent density of ~2.5 mA/cm<sup>2</sup> at 1.23 V vs. RHE under simulated AM 1.5G illumination when coated with an OER catalyst and ~2.1 mA/cm<sup>2</sup> without the OER catalyst, 47 a 1 μm-thick layer of porous BiVO<sub>4</sub> was deposited on top of a 1 µm-thick porous WO<sub>3</sub> film which was composed of multiple layers of urchin-like structures consisting of short (< 600 nm length) WO<sub>3</sub> NWs. The charge separation efficiency in the present WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs is expected to be much higher than in this heterojunction film because of the much smaller BiVO<sub>4</sub> thickness and the presence of continuous WO<sub>3</sub> NW crystals (rather than multiple layers of shorter NWs) which directly conduct electrons to the substrate.

Lastly, the stability of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs and their faradaic efficiency for water oxidation were evaluated in a three-electrode configuration with the photoanode (~1 cm<sup>2</sup> masked area) as the working electrode, a Ag/AgCl (1M KCl) reference electrode, and a Pt wire as the counter electrode. The potential of the photoanode was determined using V vs. RHE (volt) = V vs. Ag/AgCl (volt) + [0.059 (volt) × pH] + 0.236 (volt). The experiment was conducted in a sealed cell containing 0.5 M Na<sub>2</sub>SO<sub>4</sub> electrolyte (pH~ 6) through which He carrier gas was flowed at a rate of 5 sccm. After purging the electrolyte of dissolved oxygen, the potential of the photoanode was held at 1.23 V vs. RHE under simulated AM 1.5G illumination using a potentiostat, and both the photocurrent and the oxygen gas concentration in the He carrier

were monitored (Fig. 5). The concentration of oxygen in the He carrier, as measured by gas chromatography (SRI Instruments), increased and then reached a steady value at around 30 minutes once the dissolved oxygen content in the electrolyte reached a steady value. Bubbles were continuously evolved from the photoanode, and the accumulation and release of these bubbles led to the observed variations in photocurrent over the duration of the measurement. The photocurrent of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs remained at approximately 3.1 mA/cm<sup>2</sup> over 1 hour without degradation, and the faradaic efficiency for water oxidation to O<sub>2</sub> was found to be 79%. This result shows that the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs are stable and are indeed oxidizing water into O<sub>2</sub>.

In conclusion, the critical advance in this work is the use of an electrically conductive WO<sub>3</sub> NW array to overcome the intrinsically poor charge transport properties of BiVO<sub>4</sub> without compromising light absorption, thereby achieving  $\eta_{abs}$  of 69% and  $\eta_{sep}$  of 77% at 1.23 V vs. RHE, for a combined  $\eta_{abs} \times \eta_{sep}$  product of 53% which, to the best of our knowledge, is the highest achieved to date in any BiVO<sub>4</sub>-based photoanode (compared to the highest 45% previously reported<sup>18</sup>). Even without any OER catalysts, these core/shell NWs achieve a photocurrent of 3.1 mA/cm² at 1.23 V vs. RHE under precisely-simulated AM 1.5G illumination, which is quite close to the photocurrent achieved at the same potential by the best-performing BiVO<sub>4</sub>-based photoanode with OER catalysts. If the surface charge transfer efficiency of these core/shell NWs could be improved from 79% to 100% by adding OER catalysts, they would achieve a photocurrent of nearly 4.0 mA/cm² at 1.23 V vs. RHE. Importantly, the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs were synthesized from economical precursors in an inexpensive and scalable manner. These promising results bring us a step closer to efficient photoanodes for tandem PEC watersplitting systems.

### ASSOCIATED CONTENT

**Supporting Information**. Additional SEM images, histograms of nanowire dimensions, more detailed X-ray diffraction data, illumination spectra, reflectance spectra, and raw data from which conductivities were extracted. This material is available free of charge via the Internet at http://pubs.acs.org.

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#### **Author Contributions**

‡These authors contributed equally. Pratap M. Rao and Lili Cai carried out the photoanode synthesis and characterization. Pratap M. Rao, Lili Cai and Xiaolin Zheng conceived the study and wrote the manuscript. Chong Liu measured the stability and faradaic efficiency of the photoanodes and participated in revision of the manuscript. In Sun Cho assisted in preparation of reagents for the synthesis and in the electrochemical characterization, and participated in revision of the manuscript. Chi Hwan Lee performed the single-nanowire conductivity measurements. Jeffrey M. Weisse performed the thin film impedance measurements. All authors have commented on the manuscript.

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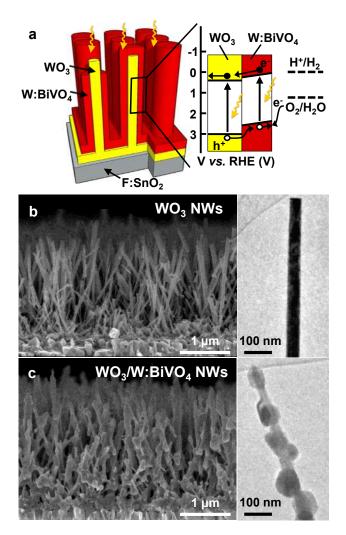
#### COMPETING FINANCIAL INTERESTS

The authors declare no competing financial interests.

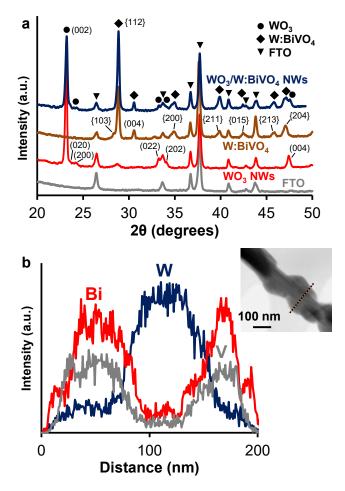
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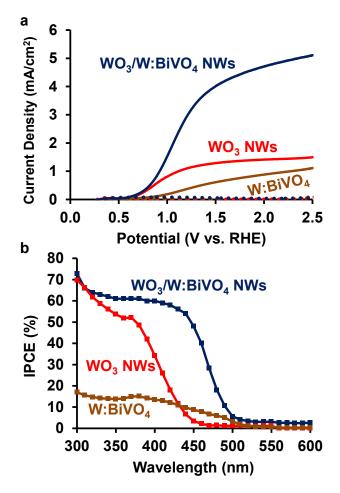
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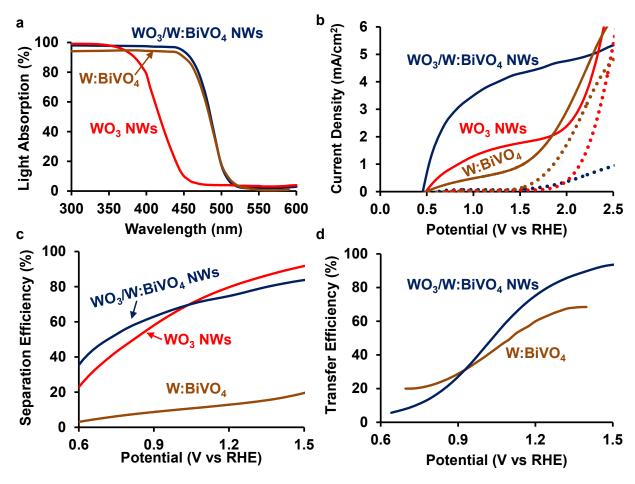
**Figure 1.** The WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell nanowire (NW) photoanode. (a) Structural schematic and energy band diagram of the core/shell NWs and type-II staggered heterojunction, in which charges generated in both the W:BiVO<sub>4</sub> shells and WO<sub>3</sub> NW cores can contribute to the water oxidation photocurrent. The band edges and water oxidation and reduction potentials are plotted on the reversible hydrogen electrode (RHE) scale. (b) and (c), Scanning electron microscope (SEM, left) and transmission electron microscope (TEM, right) images of the bare WO<sub>3</sub> NW array (75 nm average NW diameter) and WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs (60 nm average W:BiVO<sub>4</sub> shell thickness), respectively. The W:BiVO<sub>4</sub> shell consists of a single layer of densely packed nanoparticles.



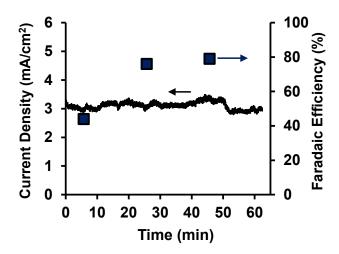
**Figure 2.** Crystallographic and chemical characterization of the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs and control samples. (a) X-ray diffraction (XRD) patterns of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs, a porous planar W:BiVO<sub>4</sub> film containing the same mass of Bi as that in the core-shell NWs (hereafter referred to as the same-mass W:BiVO<sub>4</sub> film), the bare WO<sub>3</sub> NWs, and the bare FTO (fluorine-doped tin oxide) substrate, showing that monoclinic WO<sub>3</sub> and monoclinic W:BiVO<sub>4</sub> are the only phases present in the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NWs. The (002) peak of WO<sub>3</sub> is enhanced relative to the (020) and (200) peaks, indicating that the WO<sub>3</sub> NW axis is along the [001] direction of the NW crystals. (b) Results of TEM-energy dispersive X-ray spectroscopy (TEM-EDS) on the WO<sub>3</sub>/W:BiVO<sub>4</sub> core/shell NW pictured in the inset TEM image, showing the interdiffusion of elements at the interface and gradient doping of W into the BiVO<sub>4</sub> shell.



**Figure 3.** Photoelectrochemical response of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NW photoanode and control samples in 0.5 M potassium phosphate electrolyte buffered to pH 8. (a) Current-voltage (J-V) curves (solid lines: simulated AM 1.5G illumination, dotted lines: dark) and (b) Incident photon-to-current efficiency (IPCE) measured at 1.23 V<sub>RHE</sub>.



**Figure 4.** Efficiencies of sub-processes that comprise the overall photoelectrochemical response of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NW photoanode and control samples. (a) Light absorption efficiency  $(\eta_{abs})$  and (b) J-V curve under simulated AM 1.5G illumination with H<sub>2</sub>O<sub>2</sub> added to the potassium phosphate electrolyte as a hole scavenger, which demonstrates the photocurrent achieved when the surface charge transfer efficiency is nearly 100%. (c) Charge separation  $(\eta_{sep})$  and (d) surface charge transfer efficiency  $(\eta_{trans})$  of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NWs and, where appropriate, the bare WO<sub>3</sub> NWs and same-mass W:BiVO<sub>4</sub> film.



**Figure 5.** Stability and faradaic efficiency of the WO<sub>3</sub>/W:BiVO<sub>4</sub> NW photoanode in 0.5 M Na<sub>2</sub>SO<sub>4</sub> under simulated AM 1.5G illumination.